

4.5 <u>VISHAY S.A. FRANCE</u>

4.5.1 <u>Contact Information</u>

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|---|--|
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4.5.2 Qualification

| Current Qualification Certificate No. | In QML since: | Type Designation |
|---------------------------------------|---------------|---|
| 287D | | Thin Film Technology for Chip, Wraparound, Single and Network Resistors, Fixed, Based on Types P for Single Chip, PRA and CNW for Resistor Networks |

4.5.3 Applicable Documents

ESCC Generic Specification No. 4001

ESCC Detail Specification Nos. 4001/023, 4001/025

Vishay S.A. Process Identification Document PID PID-TFD P PRA CNW

4.5.4 <u>List of Qualified Components</u>

NOTE: the Established Reliability Level R is evaluated according to ESCC specification 26000.



Characteristics: Type PHR, Variants 01 to 08, 13 and 14 are qualified:

| Detail Specification | Style | Critical R (kΩ) | Rated Dissipation (W) | Limiting Element Voltage (V) | Type Variant |
|----------------------|-------|--------------------|-----------------------|---------------------------------|--------------|
| | 0402 | 18 | 0.050 | 30 | 13; 14 |
| 4001/023 | 0603 | 12.25 | 0.100 | 35 | 01; 05 |
| | 0805 | 45 | 0.125 | 75 | 02; 06 |
| | 1206 | 40 | 0.250 | 100 | 03; 07 |
| | 2010 | 45 | 0.500 | 150 | 04; 08 |

| Variant | Style | Re | sistance Range (Note 1) | Tolerance (±%) | Temperature Coefficient | Weight | |
|---------|-------|---------|-------------------------------|-----------------------|------------------------------------|--------|--|
| vanan | Ctylo | Min (Ω) | Max (MΩ) | (Note 2) | (10 ⁻⁸ /°C) (Note 2) | (g) | |
| 01, 05 | 0603 | 10 | 0.200 (0.160 for TC « C ») | 0.01; 0.02; 0.05; 0.1 | ±5; ±10; ±25 | 0.003 | |
| 02, 06 | 0805 | 10 | 0.250 | 0.01; 0.02; 0.05; 0.1 | ±5; ±10; ±25 | 0.004 | |
| 03, 07 | 1206 | 10 | 1.000 | 0.01; 0.02; 0.05; 0.1 | ±5; ±10; ±25 | 0.01 | |
| 04, 08 | 2010 | 10 | 3.000 | 0.01; 0.02; 0.05; 0.1 | ±5; ±10; ±25 | 0.03 | |
| 13, 14 | 0402 | 10 | 0.100 (0.067 for TC « C ») | 0.01; 0.02; 0.05; 0.1 | ±5; ±10; ±25 | 0.002 | |

NOTES

1.

| Variant | Style | Critical Resistance (KΩ) |
|---------|-------|-----------------------------|
| 01 - 05 | 0603 | 12.25 |
| 02 - 06 | 0805 | 45 |
| 03 - 07 | 1206 | 40 |
| 04 - 08 | 2010 | 45 |
| 13 - 14 | 0402 | 18 |

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| Resistance (Ω) | Avalaible Tolerances (±%) | Series |
|--------------------|------------------------------|---------------------|
| $10 \le R < 50$ | 0,1 | 41 |
| $50 \le R < 100$ | 0,05 and 0,1 | Any value in the |
| $100 \leq R < 250$ | 0,02; 0,05 and 0,1 | resistance range |
| R≥250 | 0,01; 0,02; 0,05 and 0,1 | range |

| OHMIC TEMPERATURE RANGE COEFFICIENT (Ω) (ppm/°C) | | ESCC |
|--|---|------------------|
| 10 to < 20 | E: 25 (-55 °C; +155 °C) | 2 |
| 20 to < 50 | E: 25 (-55 °C; +155 °C) Y: 10 (-55 °C; +155 °C) Z: 5 (+22 °C; +70 °C) | 2 1 0 |
| ≥ 50 | E:25 (-55 °C; +155 °C) Y:10 (-55 °C; +155 °C) Z:5 (+22 °C; +70 °C) C:5 (-55 °C; +155 °C) | 2 1 0 9 |



Characteristics: Type PFRR, Variants 09 to 12 and 15 are qualified

| , variants of to 12 and 15 are quantied | | | | | | |
|---|-------|--------------------|-----------------------|---------------------------------|--------------|--|
| Detail Specification | Style | Critical R (kΩ) | Rated Dissipation (W) | Limiting Element Voltage (V) | Type Variant | |
| | 0402 | 32 | 0.050 | 40 | 15 | |
| 4001/023 | 0603 | 25 | 0.100 | 50 | 09 | |
| | 0805 | 80 | 0.125 | 100 | 10 | |
| | 1206 | 90 | 0.250 | 150 | 11 | |
| | 2010 | 80 | 0.500 | 200 | 12 | |

| Style | Resistance Range (Ω) | Tolerance (±%) | Temperature Coefficient TC(±10 ⁻⁶ /°C) |
|------------------------------|-----------------------------|----------------|--|
| 0402; 0603; 0805; 1206; 2010 | From 100 to ≤ 100K | 0.05; 0.1 | 10; 25 |
| 0603; 0805; 1206; 2010 | From 100 to ≤ 261K | 0.05; 0.1 | 10; 25 |
| 0805; 1206; 2010 | From 261K to ≤ 301K | 0.05; 0.1 | 10; 25 |
| 1206; 2010 | From 301K to ≤ 1M | 0.05; 0.1 | 10; 25 |
| 2010 | From 1M to 3M01 | 0.05; 0.1 | 10; 25 |

Characteristics: Type PRAHR/CNWHR,, Variants 01 to 42 are qualified

| Detail Specification | Style | Critical R | Rated Dissipation | Limiting Element | Type | /ariant |
|-----------------------------|--------|------------|-------------------|-------------------------|-------------------------|------------------------------|
| | | (ΚΩ) | (W/resistor) | Voltage (V/resistor) | Same Ohmic Values | Different Ohmic Values |
| | PRA100 | 12.25 | 0.100 | 35 | 01 to 07 | 22 to 28 |
| 4001/025 | PRA135 | 56.25 | 0.100 | 75 | 08 to 14 | 29 to 35 |
| | PRA182 | 100 | 0.100 | 100 | 15 to 21 | 36 to 42 |

| Style | Resistance Range (Ω) | Tolerance (±%) | | Temperature Coefficient $TC(\pm 10^6)$ °C) | |
|------------------------|-----------------------------|-------------------|-----------|--|----------|
| | | Absolute | Relative | Absolute | Relative |
| PRA100; PRA135; PRA182 | From 100 to 200K | 0.1; 0.5; 1 | 0.05; 0.1 | 10 | 3; 5 |
| PRA135; PRA182 | From 200K to 250K | 0.1; 0.5; 1 | 0.05; 0.1 | 10 | 3; 5 |
| PRA182 | From 250K to 1M | 0.1; 0.5; 1 | 0.05; 0.1 | 10 | 3; 5 |

Number of Resistors per Array: 2 to 8

NOTES:

- 1. Note that gold finish variants are not intended for de-golding and tinning.
- The electrical ranges of these ESCC QML Qualified components variants are listed in the ESCC Detail Specifications and in the Qualified Part List (REP005) document available on the ESCIES website, https://escies.org.



4.5.5 <u>Technology Flow Abstract</u>

1. Technology Flow

The thin film technology for chip, fixed, wraparound, single and network resistors are designed on types based on P for single chip, PRA for 2 to 8 resistors of similar value and CNW for 2 to 8 resistors with at least two different values with the same form factor as PRA.

| Technology Flow | Scope | Site |
|-----------------|--|---|
| Design Centre | Single resistor chips in 0402 0603, 0805, 1206 and 2010 formats 2 to 8 resistors of similar value in formats 0603, 0805 and 1206 2 to 8 resistors with at least 2 different values with the same form factor, 0603, 0805 or 1206 | Vishay S.A. Division SFERNICE 199, Boulevard de la Madeleine CS71159 F-06003 Nice Cedex 01 France |
| Fabrication | Film deposition Photolithography Thermal treatment Passivation Thermal stabilization and control | As above |
| Assembly | Laser trim Protective layer Termination and Test | As above |
| Test | Chart F2, F3 and F4 Periodic Testing | As above |

(a) Basic Information

The technology consists of:

Substrate: High purity alumina (99.5%)

Resistive Layer: Nickel chromium

Passivation Layer: Silicon Nitride

- Protection: Epoxy and Silicone

Termination: Nickel barrier

Processes: Thin film deposition

Finish: SnPbAg or Au

Critical resistance by style:

- P 0402 FR:32 k
- P 0603 FR:25 k
- P 0603 HR:12.25 k
- P 0805 FR: 80k
- P 0805 HR: 45 k
- P 1206 FR: 90 k
- P 1206 HR: 40 k
- P 2010 FR: 80k
- P 2010 HR: 45 k
- PRA 100: 12.25 k



PRA 135: 56.25 kPRA 182: 100 k

(b) Component Types

The available formats are defined in the variants table in the Detail Specifications. Variants with established reliability in accordance with Basic specification No. 26000 are designated with an "FR" suffix here for convenience. Variants 09, 10, 11 and 12 have established reliability level 'R' at 60% confidence level.

6. Design

The design manuals covers the design rules and limits:

- HP-BE/001 (Maîtrise de la conception)
- HP-BE/004 (Données technologiques, Régles d'implementation, Performances)

Critical design characteristics:

- Minimum metal width: 10 µm
- Power dissipation lower than 250mW/mm²
- Current density lower than 7000 A/mm²
- Electrical field lower than 5V/ µm

3. Fabrication/Assembly

The manufacturing flows and procedures are described in section 4 of Vishay S.A.PID.

4. Test

Complete test sequence as detailed in ESCC Generic 4001 and the relevant Detail Specifications is conducted by Vishay S.A.

The deletion of the Third Harmonic Control requirement from ESCC Detail Specification No. 4001/023 for thin film wraparound technology is documented in reference report MAT/3HC/07.02 revision 3 dated 2007-06-20.

For variants with established reliability the efficiency of the Overload Test is increased with the implementation of a resistance change rejection criteria of 500 ppm and approved by TRB decisions on 2007-04-04.

5. Radiation Characteristics

The resistors covered in this technology domain is considered insensitive to radiation effects.